

BUK7C08-55AITE

N-channel TrenchPLUS standard level FET

Rev. 02 — 17 February 2009

Product data sheet

Product profile 1.

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS current sensing and diodes for ElectroStatic Discharge (ESD) protection and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Electrostatically robust due to integrated protection diodes

1.3 Applications

- Automotive and general purpose power switching
- Fan control

1.4 Quick reference data

- Low conduction losses due to low on-state resistance
- Q101 compliant
- Reduced component count due to integrated current sensor
- Electrical Power Assisted Steering (EPAS)
- Variable Valve Timing for engines

Table 1.	Quick reference						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	55	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; see <u>Figure 2;</u> see <u>Figure 3</u>	[1]	-	-	130	А
Static ch	naracteristics						
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 50 A; T_j = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>		-	6.8	8	mΩ
I _D /I _{sense}	ratio of drain current to sense current	T _j > -55 °C; T _j < 175 °C; V _{GS} > 5 V		450	500	550	
S _{F(TSD)}	temperature sense diode temperature coefficient	I _F = 250 μA; T _j > -55 °C; T _j < 175 °C		-1.4	-1.54	-1.68	mV/K
V _{F(TSD)}	temperature sense diode forward voltage	I _F = 250 μA; T _j = 25 °C		648	658	668	mV

[1] Current is limited by power dissipation chip rating.

nexperia

N-channel TrenchPLUS standard level FET

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		d a
2	ISENSE	sense current	mb	
3	А	anode		
4	D	drain	i i !'	
5	К	cathode		
6	KS	Kelvin source	123 567	
7	S	source	SOT427	MBL362 Isense Kelvin source
mb	D	mounting base; connected to drain	(D2PAK)	MDL302 SEI13E KEIVIII SUUCE

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK7C08-55AITE	D2PAK	plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped)	SOT427

4. Limiting values

Table 4. Limiting values

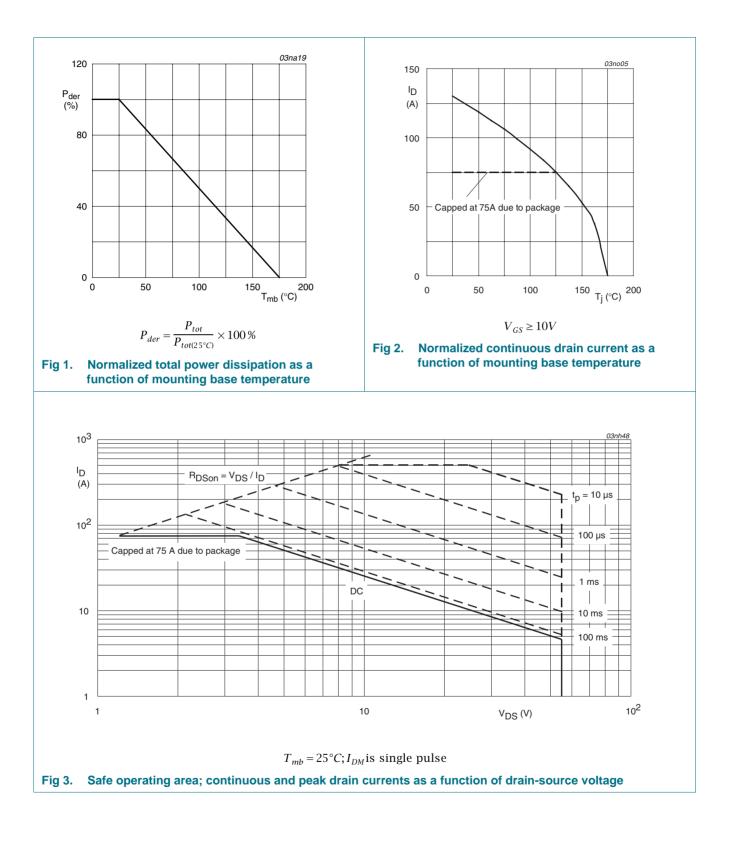
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	55	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	55	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 2</u> ;	[1]	-	130	А
		see Figure 3	[2]	-	75	А
		T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 2</u>	[2]	-	75	А
I _{DM}	peak drain current	$T_{mb} = 25 \text{ °C}; t_p \le 10 \mu\text{s}; \text{ pulsed}; \text{ see } \frac{\text{Figure } 3}{10 \mu\text{s}}$		-	522	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	272	W
I _{GS(CL)}	gate-source clamping	continuous		-	10	mA
	current	pulsed; $t_p = 5 \text{ ms}; \delta = 0.01$		-	50	mA
$V_{isol(FET-TSD)}$	FET to temperature sense diode isolation voltage			-100	100	V
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drain	n diode					
I _S	source current	T _{mb} = 25 °C	[1]	-	130	А
			[2]	-	75	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	522	А
Avalanche ru	uggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D = 75 \text{ A}; V_{sup} \leq 55 \text{ V}; \text{R}_{GS} = 50 \Omega; \text{V}_{GS} = 10 \text{ V}; \\ T_{j(\text{init})} = 25 ^{\circ}\text{C}; \text{ unclamped} \end{split}$		-	460	mJ
Electrostatic	discharge					
V _{esd}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 k Ω		-	6	kV

[1] Current is limited by power dissipation chip rating.

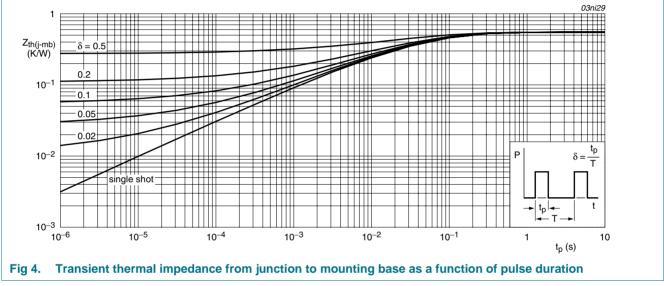
[2] Continuous current is limited by package.

BUK7C08-55AITE



5. Thermal characteristics

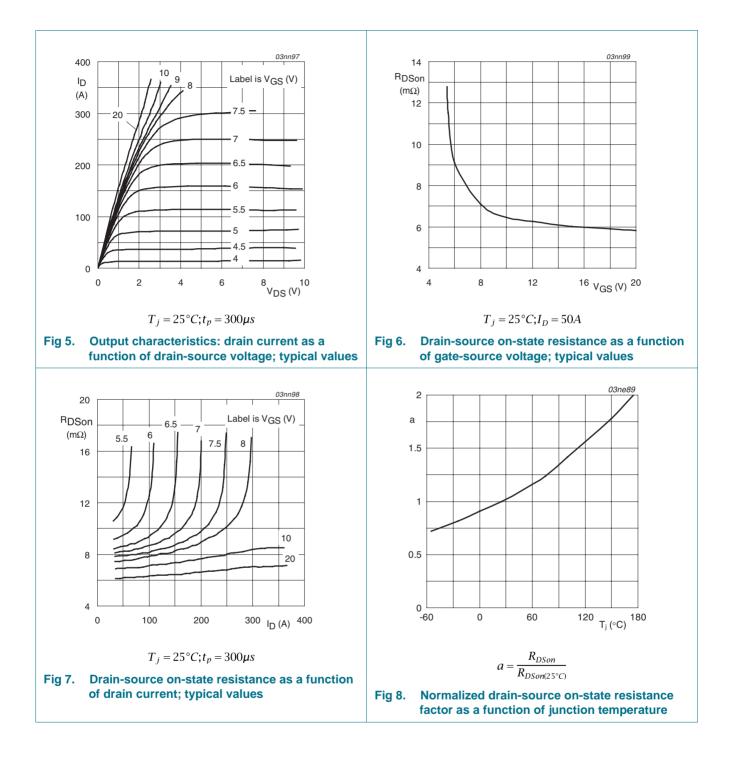
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	mounted on printed-circuit board; minimum footprint	-	-	50	K/W
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W



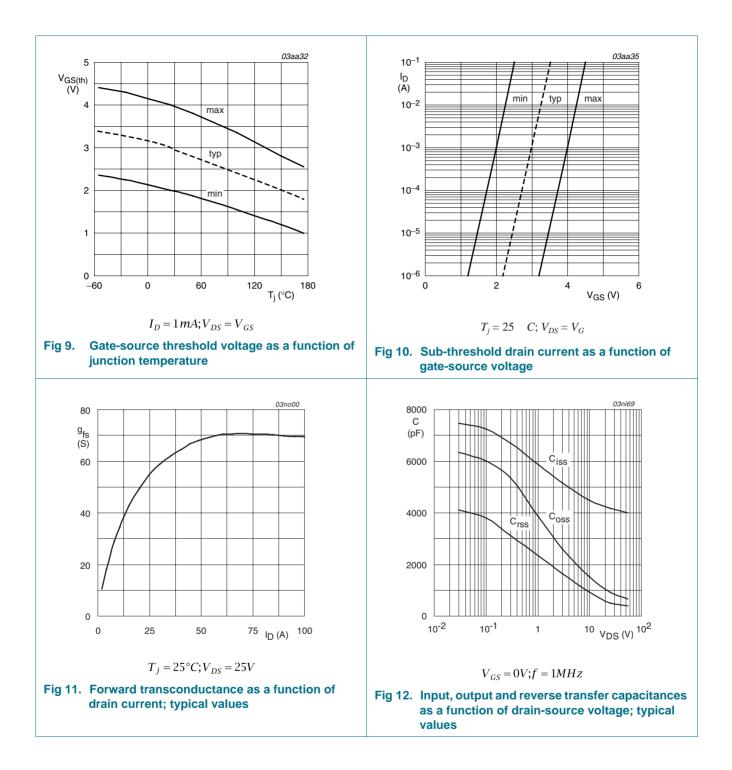
6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	acteristics					
V _{(BR)DSS}	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	55	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	50	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 9	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 9	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see Figure 9	-	-	4.4	V
I _{DSS}	drain leakage current	V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C	-	0.1	10	μΑ
		$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	250	μΑ
V _{(BR)GSS}	gate-source breakdown voltage	$I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
		I_G = -1 mA; V_{DS} = 0 V; T_j > -55 °C; T_j < 175 °C	20	22	-	V
I _{GSS}	gate leakage current	$V_{DS} = 0 V; V_{GS} = 10 V; T_j = 25 °C$	-	22	1000	nA
		V _{DS} = 0 V; V _{GS} = -10 V; T _j = 25 °C	-	22	1000	nA
		V _{DS} = 0 V; V _{GS} = 10 V; T _j = 175 °C	-	-	10	μA
		V _{DS} = 0 V; V _{GS} = -10 V; T _j = 175 °C	-	-	10	μA
R _{DSon} drain-source on-s resistance	drain-source on-state resistance	V _{GS} = 10 V; I _D = 50 A; T _j = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	-	6.8	8	mΩ
		V_{GS} = 10 V; I_D = 50 A; T_j = 175 °C; see Figure 7; see Figure 8	-	-	16	mΩ
R _{(D-ISENSE)on} drain-ISENSE on-state resistance		V_{GS} = 10 V; I _D = 25 mA; T _j = 25 °C; see <u>Figure 18</u>	1.32	1.55	1.82	Ω
		V_{GS} = 10 V; I _D = 25 mA; T _j = 175 °C; see Figure 18	3.04	3.57	4.19	Ω
V _{F(TSD)}	temperature sense diode forward voltage	$I_F = 250 \ \mu A; \ T_j = 25 \ ^\circ C$	648	658	668	mV
S _{F(TSD)}	temperature sense diode temperature coefficient	I _F = 250 μA; T _j > -55 °C; T _j < 175 °C	-1.4	-1.54	-1.68	mV/K
V _{F(TSD)hys}	temperature sense diode forward voltage hysteresis	$I_F > 125 \ \mu A; I_F < 250 \ \mu A; T_j = 25 \ ^\circ C$	25	32	50	mV
I _D /I _{sense}	ratio of drain current to sense current	V _{GS} > 5 V; T _j > -55 °C; T _j < 175 °C	450	500	550	
Dynamic c	haracteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 10 \text{ V};$	-	116	-	nC
Q _{GS}	gate-source charge		-	19	-	nC
Q _{GD}	gate-drain charge		-	51	-	nC

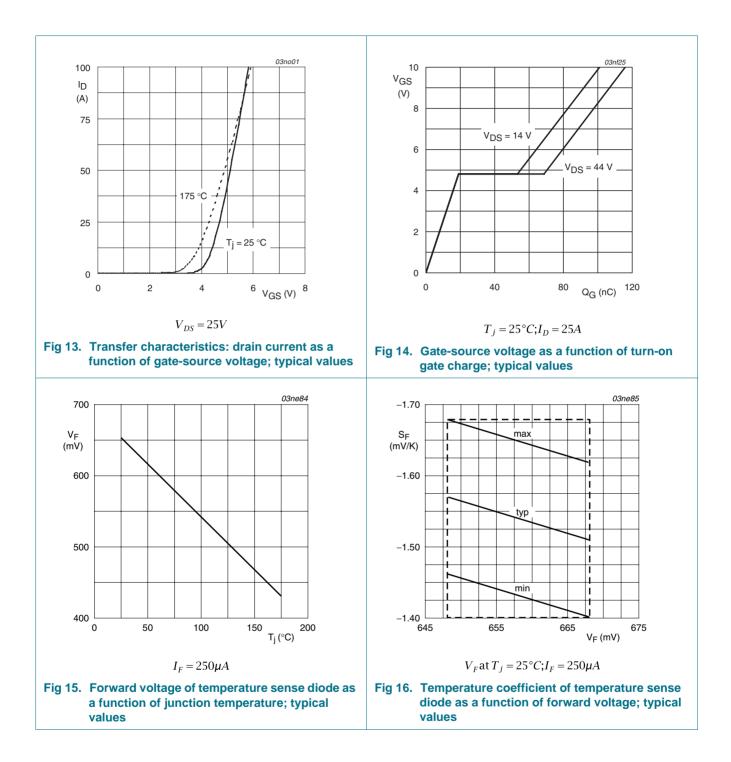
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	4200	-	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 12}{\text{Figure } 12}$	-	920	-	pF
C _{rss}	reverse transfer capacitance		-	500	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 30 V; R_L = 1.2 Ω; V_{GS} = 10 V;	-	35	-	ns
t _r	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	115	-	ns
t _{d(off)}	turn-off delay time		-	155	-	ns
t _f	fall time		-	110	-	ns
L _D	internal drain inductance	measured from upper edge of drain mounting base to centre of die; $T_j = 25 ^{\circ}\text{C}$	-	2.5	-	nH
L _S	internal source inductance	measured from source lead to source bond pad; $T_j = 25 \text{ °C}$; lead length 6 mm	-	7.5	-	nH
Source-dra	ain diode					
V _{SD}	source-drain voltage	I _S = 40 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 19</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	I_S = 20 A; dI_S/dt = -100 A/µs; V_{GS} = -10 V;	-	80	-	ns
Q _r	recovered charge	V _{DS} = 30 V; T _j = 25 °C	-	200	-	nC



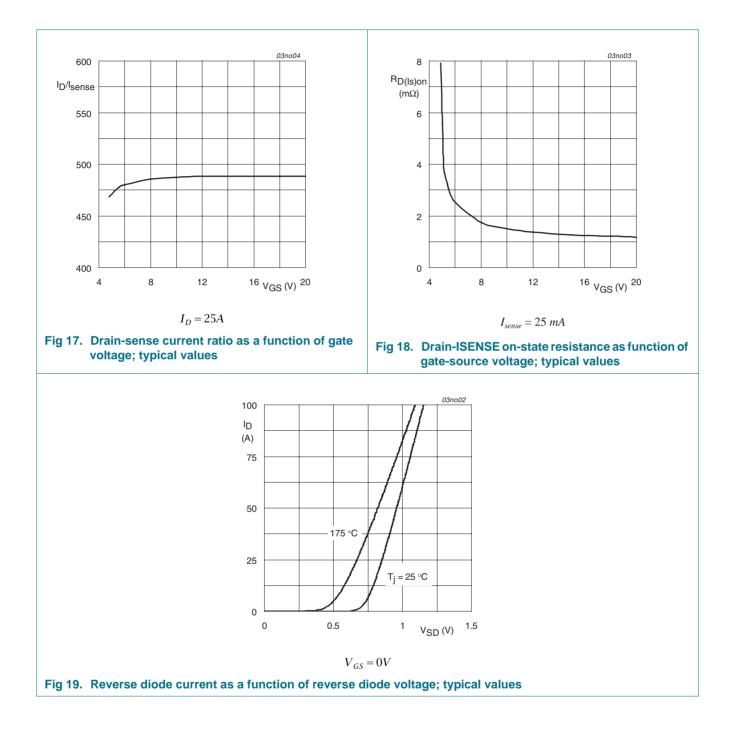
BUK7C08-55AITE



BUK7C08-55AITE



BUK7C08-55AITE



N-channel TrenchPLUS standard level FET

7. Package outline

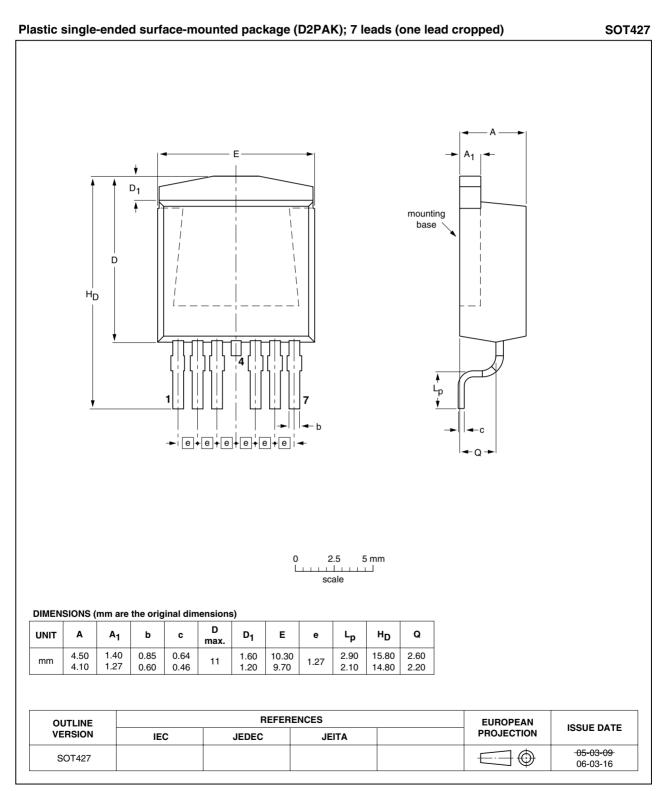


Fig 20. Package outline SOT427 (D2PAK)

8. Revision history

Table 7. Revision his	tory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7C08-55AITE_2	20090217	Product data sheet	-	BUK7C08_55AITE-01
Modifications:		of this data sheet has been of NXP Semiconductors.	en redesigned to comply	with the new identity
	 Legal texts 	have been adapted to the	new company name w	here appropriate.
BUK7C08_55AITE-01 (9397 750 11696)	20030819	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nexperia.com.

9.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. Nexperia does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local Nexperia sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

9.3 Disclaimers

General — Information in this document is believed to be accurate and reliable. However, Nexperia does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — Nexperia reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — Nexperia products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of a Nexperia product can reasonably be expected to result in personal injury, death or severe property or environmental damage. Nexperia accepts no liability for inclusion and/or use of Nexperia products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

10. Contact information

For more information, please visit: http://www.nexperia.com

For sales office addresses, please send an email to: salesaddresses@nexperia.com

Applications — Applications that are described herein for any of these products are for illustrative purposes only. Nexperia makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — Nexperia products are sold subject to the general terms and conditions of commercial sale, as published at <u>http://www.nexperia.com/profile/terms</u>, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by Nexperia. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

9.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

N-channel TrenchPLUS standard level FET

11. Contents

1	Product profile1
1.1	General description1
1.2	Features and benefits1
1.3	Applications1
1.4	Quick reference data1
2	Pinning information2
3	Ordering information2
4	Limiting values3
5	Thermal characteristics5
6	Characteristics6
7	Package outline12
8	Revision history13
9	Legal information14
9.1	Data sheet status14
9.2	Definitions14
9.3	Disclaimers
9.4	Trademarks14
10	Contact information14